

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277
Hisayuki KATO : Confirmation Number:
Serial No.: : Group Art Unit:
Filed: August 28, 2003 : Examiner: Unknown
For: SEMICONDUCTOR DEVICE HAVING FUSE

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The relevance of the Japanese Patent Laying-Open Nos. 2000-311947, 2001-44281, 10-321726, and 9-17877 are discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION			ATTY. DOCKET NO. 67161-088		SERIAL NO.	
			APPLICANT Hisayuki KATO			
(PTO-1449)			FILING DATE August 28, 2003		GROUP	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ₂ (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US 2003/0057528 A1	03/27/2003	Sasaki		
		US 5,608,257	03/04/1997	Lee et al.		
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FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code ₃ -Number & Kind Codes (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
		JP P2000-311947A	11/07/2000	NEC CORP		(w/English Abstract)
		JP P2001-44281A	02/16/2001	MITSUBISHI ELECTRIC CORP		(w/English Abstract)
		JP 10-321726	12/04/1998	NKK CORP		(w/English Abstract)
		JP 9-17877	01/17/1997	INTERNATL BUSINESS MACH CORP <IBM> SIEMENS AG		(w/English Abstract)
		JP 11-224900	08/17/1999	TOSHIBA CORP		(w/English Abstract)
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
EXAMINER			DATE CONSIDERED			

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Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.